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Stacked Platform

VULCANO XYZ3TH

ETEL

version 2.4 - 03/20 - subject to modifications without previous notice

ETEL



The VULCANO XYZ3T^H stacked platform is a 9 axes platform moving in X, Y, Z, Tip-Tilt and Theta directions. It is a mechanical bearing stage integrating ironcore linear motors as well as high precision optical encoders, and mainly dedicated to point-to-point applications.

The VULCANO XY part of it is a three-piece-design stacked system resulting in a cost engineered solution combining high dynamics, great bidirectional repeatability, and outstanding position stability.

The bottom axis is composed of two linear motors controlled in a gantry mode moving on three decoupled linear bearings. The upper linear motor lays on a stiff and light baseplate allowing travels up to 650 mm.

The stage is modular and can be outfitted with the module best suited to each individual application.

VULCANO XYZ3TH PLATFORM

This platform can also be integrated with ETEL's QuiET Active Isolation System to reach ultimate performance.

The standard platform shown above includes an ETEL Z3TH combined module on the XY assembly. The Z3TH combined module provides 364° Theta rotation, a Tip-Tilt correction over $\pm 0.1^\circ$ and dual Z-axes: a coarse Z axis for wafer loading and unloading, and a fine Z axis for precision motion. The Z3TH module allows a reduction of XY move and settle times and a correction of the stage flatness.

Other modules moving in Theta or ZTheta can also be considered.

PERFORMANCE

	Y1-Y2	X	FINE Z	TIP-TILT	COARSE Z	THETA
Total stroke	490 mm	420 mm	±2 mm	±0.1°	12 mm	364°
Speed	Up to 1.5 m/s	Up to 1.5 m/s	0.05 m/s	-	0.1 m/s	10 rad/s
Acceleration	Up to 2.5 g	Up to 2.5 g	0.1 g	-	0.2 g	55 rad/s²
Position stability	<±1 nm	<±1 nm	±2 nm	±0.004 arcsec	-	±0.004 arcsec
Bidir. repeatability	Down to ±250 nm		±10 nm	-	-	±0.35 arcsec
Move and settle times 25 mm within ±100 nm	<130 ms		÷	-	-	-
Typical payload	-	-	-	-	0.15 kg	1 kg

PRODUCT HIGHLIGHTS

- Compact footprint
- Nanometer position stability
- · High dynamics: 2.5 g, 1.5 m/s
- Low move and settle times
- ISO1 clean room compatible
- Tip-Tilt correction over ±0.1°
- · Double Z integration
- Built-in gravity compensator in Z
- Outstanding Z straightness
- · Enhanced Z repeatability and jitter
- · Ability to correct stage flatness
- · Built-in vacuum supply at chuck level

TYPICAL APPLICATIONS

The use of this platform is suitable for, but not limited to:

- Wafer Process Control applications such as Overlay Metrology, Critical Dimension and Thin film Metrology
- Advanced packaging applications